Pinpoint Defective Capacitors,
Coils, And Special Components That
All Other Testers Miss — Without
Guesswork, Look-up Charts, Or
Calculation Errors . . .



... with the LC102 "AUTO-Z"



Introducing The LC102 AUTO-Z

by Terry Cook, IEEE LC102 Design Team Leader

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How Do Capacitors Fail?

Conventional testers check for value; but our research shows that only 25% of all capacitor problems are related to value change. Conventional testers miss the other 75% that fail because of leakage, dielectric absorption or equivalent series resistance (ESR).



Value. Testing for value is easy; you simply push a button and read the display. The problems start when you try to determine if the reading is within tolerance. You usually

have to grab your calculator and figure the percentage of variation which takes time and can introduce errors. To make matters worse, most value testers read out in nanofarads and millifarads forcing you to make more calculations to convert to standard values.



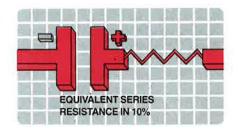
Leakage. Leakage develops when the capacitor has an internal parallel resistance that bypasses current through the dielectric. Excessive leakage may cause problems in filtering and high impedance circuits.

Finding leaky capacitors is difficult because it requires a complex set-up and the test must be made at the capacitor's working voltage. Plus the leakage reading may be meaningless unless you reference a standards table. For example: how much leakage can a 2,200 uF, 950 V electrolytic have before it causes problems in the circuit?



Dielectric Absorption. Dielectric absorption (D/A) is the capacitor's inability to completely discharge. D/A in a capacitor acts as a battery that changes the circuit's bias voltage, and it changes the capacitor's value 'in-circuit'. We found that 25% of the capacitors tested in our study failed because of excessive D/A.

A conventional D/A test procedure requires an electrometer and takes several hours to complete. Plus, once again, you have to interpret the reading to determine if it's going to work in the circuit.



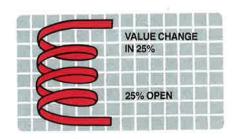
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ESR is impossible to test with an ohmmeter, since you cannot connect across these internal resistances. If you do have an ESR test available, you're back to interpreting readings. Does a 30,000 uf electrolytic with 2.3 ohms of ESR need to be replaced or can it be used in the circuit?

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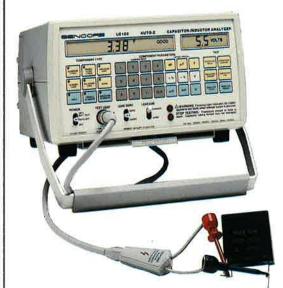
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Inductors fail in one of two ways. They change value, which includes an open, or they develop a shorted turn. How do these values affect your tests?



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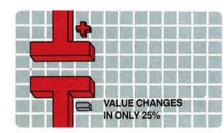
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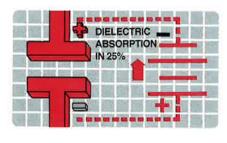
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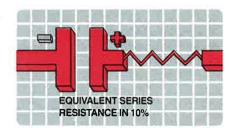
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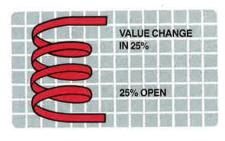


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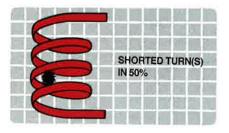
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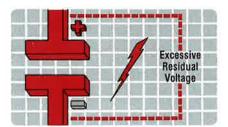
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Discover The Z Standard. It's the future of LCR analyzing technology, that's here now . . .



Automatically And Dynamically Analyze Any Capacitor From 1.0 pf To 20 Farads To EIA And Industry Standards.

TEST

COMPONENT PARAMETERS

TEST

COMPONENT PARAMETERS

TEST

TOTAL

TOT

ENTER: The capacitor's type, value, tolerance, and working voltage.

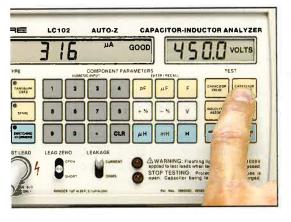
Capacitor Value—Patented

The microcomputer in the LC102 compares the value to the tolerances you've entered. If the cap falls within tolerance, the display will show ''GOOD''. If it doesn't, the display will show ''BAD''. No interpretation or guesswork.

PUSH: The CAPACITOR VALUE button.

READ: CAPACITOR VALUE in picofarads, microfarads and farads plus "GOOD"

or "BAD" according to the tolerance you've entered.



Capacitor Leakage

The LC102 AUTO-Z tests the capacitor at its working voltage with up to 1,000 volts DC applied. The AUTO-Z's internal microcomputer compares the capacitor type, value and applied voltage to calculate the maximum allowable leakage as defined by EIA specifications programmed into its memory. The display shows "GOOD" or "BAD" according to the leakage reading. Finding leaky caps is as simple as pushing a button.

PUSH: The CAPACITOR LEAKAGE button.

READ: LEAKAGE in microamps or milliamps plus "GOOD" or "BAD" according to

EIA standards.



Capacitor Dielectric Absorption—Patented

The LC102 AUTO-Z automatically goes through the steps needed to measure the dielectric absorption. It then compares the reading to its internal standards tables based on type, value, and voltage and displays either ''GOOD'' or ''BAD''. You don't have to decide if the cap has excessive D/A — the AUTO-Z does it for you.

PUSH: The DIELECTRIC ABSORPTION button.

READ: DIELECTRIC ABSORPTION as a percentage plus "GOOD" or "BAD"

according to internal D/A standards.

LC102 AUTO-Z CAPACITOR-INDUCTOR ANALYZER GOOD VOLTS TYPE COMPONENT PARAMETERS ORIGINATER TEST COMPONENT PARAMETERS ORIGINATER ORIGINATER TEST COMPONENT PARAMETERS ORIGINATER TEST COMPONENT PARAMETERS ORIGINATER TEST COMPONENT PARAMETERS ORIGINATER ORIGINATER SETIMATER ORIGINATER ORIG

Capacitor ESR—Patented

The LC102 AUTO-Z measures the capacitor's ESR and compares this reading to internal EIA Capacitor Tables and industry standards. If the ESR is within tolerance, the LC102 displays "GOOD" and if not, it displays "BAD". You have positive proof the capacitor will work in the circuit.

PUSH: The CAPACITOR ESR button.

READ: ESR in ohms and either "GOOD" or "BAD" according to internal EIA

tables.

LC102 "AUTO-Z" Capacitor/Inductor Analyzer

Capacitor & Inductor Characteristics

Measure capacitor value, leakage, dielectric absorption, and ESR as well as inductor value and patented ringing test.

GOOD/BAD Test

Eliminates guesswork as it automatically compares the parameters of the component under test to internal EIA and industry standards tables.

DC Voltage

Applies DC from 1 volt to 1000 volts in programmable 0.1 V steps. (For capacitor leakage & hi-pot tests.)

Capacitor And Inductor Tests

Delivers all the market proven Z Meter tests at the push of a button.

New Alert System

New audible and visual alert warns you if

your Z Meter's fuse is open, and potential

remains on the component under test.

Component Parameters

Program in the parameters and the LC102 determines if the component falls within its specified tolerance.

Component Type

Enter capacitor or inductor type (the LC102 references internal EIA tables according to component type).

Portable, Battery Operated

Provides 9 hours of capacitor and inductor testing in the field or in the factory.

SENCORE LC102 AUTO-Z CAPACITOR-INDUCTOR ANALYZER GOOD VOLTS **COMPONENT TYPE COMPONENT PARAMETERS TEST** DOUBLE LAYER LYTICS CAPACITOR CAPACITOR TANTAL CERAMIC ALL OTHER DIELECTRIC CAPACITOR YOKES & FLYBACKS SWITCHING XFORMERS INDUCTOR INDUCTOR COILS

POWER

Actual Size

AUTO OFF

115 VAC OR BATT

TEST LEAD



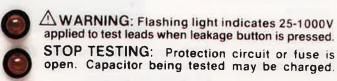
LEAD ZERO



ANGES: 1pF to 20 F. 0.1 uH to 20H



LEAKAGE



Pat Nos. 3990002, 4258315, 4267503, Others Pending

Automatic Lead Zero

Removes stray lead inductance, capacitance, and resistance, and assures accurate readings.

Leakage In Current Or Ohms

Tests capacitor leakage up to 1000 volts DC applied or insulation leakage (Hi-Pot Tester) to 1,000,000,000 ohms.



RS232 Compatible Call 1-800-SENCORE (736-2673)

Dynamically Test Any Inductor From .1 uH To 20 Henrys 100% Automatically, Plus Test Special Components, Anytime, Anywhere.

ENTER: The inductor type, value, and tolerance.

Inductor Value—Patented

The LC102 AUTO-Z measures true inductance, not inductive reactance. The microcomputer in the LC102 compares the value and the percentage difference from its specified value. If the inductor falls within tolerance, the display shows ''G00D''. If it doesn't, the display shows ''BAD''. It's that simple.

PUSH: The INDUCTOR VALUE button.

READ: INDUCTOR VALUE is displayed plus a "GOOD" or "BAD"

reading depending on the tolerance you've entered.

LC102 AUTO-Z CAPACITOR-INDUCTOR ANALYZER TYPE COMPONENT PARAMETERS DATE: PEST CAPACITOR TEST CAPACITOR TOTAL TOTAL CAPACITOR TOTAL TOTAL

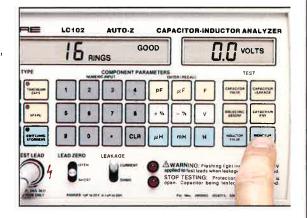
Inductor Ringing—Patented

The LC102 strikes the coil with a sharp waveform and counts the number of resulting resonant rings. According to extensive studies completed at Sencore, a "good" coil will ring more than 10 times. The Ringing Test is an industry standard that has been used in more than 60,000 Sencore instruments and it works every time.

PUSH: The INDUCTOR RINGER button,

READ: The number of "RINGS" is displayed plus "GOOD" if the number is

greater than 10 and "BAD" if it's less than 10.



Resistance Test (1,000 megohm hi-pot tester)

The LC102 is sensitive enough to detect as little as .01 microamp of leakage current in connectors, PC boards, and switches. With the flip of a switch the LC102 becomes a hi-pot tester that measures resistance up to 1,000 megohms with up to 1,000 volts DC applied. *Enter DC test voltage*.

PUSH: The CAPACITOR LEAKAGE button.

READ: LEAKAGE in microamps or milliamps. Flip the switch

and read RESISTANCE in ohms, kilohms or megohms.



Portability

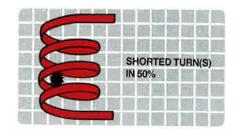
The LC102 AUTO-Z operates on 120 VAC or optional battery pack so you can take it wherever you do capacitor and inductor testing. Take the LC102 along with you to service large main frame computers, industrial machines, or remote antenna networks. The LC102 works all day on one charge.

PLUS:

- Automatically pinpoint transmission line opens and shorts by measuring line capacitance or inductance.
- Test SCRs and triacs for leakage, latching and gate operation.
- Automate repetitive cap and coil analyzing with computerized testing.



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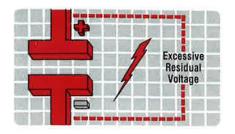
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Tests and Specifications for the LC102 AUTO-Z

Capacitor Value: RANGE: 1.0 pF to 19.99F fully autoranged ACCURACY: ±1% ±1 pF ± 1 digit up to 1990 uF ± 5% ± .1% of range full scale for 2000 uF to 19.99 F RESOLUTION: .1 pF on lowest range to .01 F on highest range: 12 ranges total Automatically read GOOD or BAD according to tolerance selected on keypad Double layer lytics patent applied for

Capacitor Leakage Voltage: VOLTAGE RANGE: 1.0V to 999.9V in 0.1V steps VOLTAGE ACCURACY: +0% -5% POWER: Short circuit current limited to <900 mA. Continuous power limited to 6

Watts ± 10% Selected on keypad

Capacitor Leakage (current): RANGE: 0.01 uA to 19.99 mA fully autoranged ACCURACY: ±5% ±1 digit RESOLUTION: 0 01 uA to 01 mA for 0 01 uA to 19 99 mA in four ranges VOLTAGE: Maximum reading determined by voltage setting

As A Dynamic Ohmmeter: RANGE: 100 Ohms to 999 megohms depending on voltage setting ACCURACY: ±5% ±1 digit.

Capacitor Dielectric Absorption Test: RANGE: 1 to 100% RESOLUTION: 1% ACCURACY: ±5% of reading, ±1 digit.

CAPACITOR RANGE: 0.01 uF to 19 99 F. Automatically reads GOOD or BAD on electrolytics at 15 percent variation in reading after charge and discharge; less for other capacitors U.S. patent number 4,267,503.

Capacitor Equivalent Series Resistance (ESR): RANGE: 0 10 ohm to 1999 ohms fully autoranged ACCURACY: ±5% ±1 digit. RESOLUTION: .01 ohms to 1 ohm, on high end in three ranges CAPACITOR RANGE: 1 uF to 19 99 F. U.S. patent number 4,795,966

Inductor Value: RANGE: 0.10 uH to 19.99 H fully autoranged ACCURACY: ±2% ±1 digit RESOLUTION: .01 uH for 20 uH range to .01 H for 19.99 H range: 9 automatic ranges U.S. patent number 4,258.315

Ringing Test: Excites inductor with sharp wavefront of 5 volts peak amplitude 60 Hz. ACCURACY: ±1 count from readings of 8 to 13: 10 rings or more automatically indicated as GOOD. Automatically selects correct impedance match to produce maximum

RESOLUTION: ±1 digit U.S. patent number 3,990,002

General: TEMPERATURE: Operating range 32 to 104 degrees F (0-40 degrees C). Specified accuracy range 50 to 86 degrees F (10-30 degrees C) HUMIDITY: To 90% RH, no condensation.

DISPLAY: 6 digit LCD; auto decimal placement; leading zero suppression; pF, uF, F uA, mA, %, KΩ, MΩ, ohms, uH, mH, H, V, RINGS, SHORT, OPEN, WAIT, GOOD, and BAD annunciators, overranged indication.

POWER: 105-135 VAC 60 Hz with supplied PA251 power adapter. Battery with optional BY234, 2.0 AH battery for 9 hours continuous typical battery life. Auto off approximately 20 minutes after use. Auto off overridden when using external

SIZE AND WEIGHT: 6 ' x 9'' x 11.5" HWD (15.2 x 22.6 x 29.2 cm.), 6 lbs (2.7 kg.) without battery, 7.6 lbs. (3.5 kg.) with battery

Accessories for the LC102 AUTO-Z



SCR250: SCR and Triac Test Accessory™ \$168

The SCR250 tests all SCRs and triacs for turn-on capability and leakage, even in high current industrial SCRs and triacs...Its isolated, and has a separate controlled supply to protect sensitive IB72: IEEE 488 Bus Interface Accessory™ \$625

Automate the LC102 to save time and money in incoming inspection, quality assurance, or wherever you need to test a large number of components. The IB72 allows you to interface the LC102 with a personal computer or controller.



FC221: Field Calibrator Accessory \$65 Test your AUTO-Z's calibration quickly with this handy LC standard.

BY234: Battery Pack Accessory \$59.95 Go anywhere for up to 9 hours with this optional battery pack.

IB78 RS232 Interface Accessory \$395 Use to operate the AUTO-Z with an RS232 computer or controller for automated test.

CC254: Z Meter Carrying Case \$99 Protect your AUTO-Z with this waterproof and

padded stylish case.

CH255: Component Holder \$195

Test radial and axial lead components quickly with this convenient accessory.

CH256: Chip Component Test Lead \$49 Test surface mount components quickly with this tweezer-like accessory.

39G85 Touch-Test Test Probe \$17 Save time with in-circuit inductor testing. No need to unsolder leads.

Here's How to Order

Call 1-800-SENCORE (736-2673) and we'll help you discover dynamic LC analyzing and what it will do for you.

AUTO-Z is a trademark of Sencore, Inc.



It's like having your own Standards Engineer with you at all times.



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